

Notice of References Cited

Application/Control No.

09/731,280

Applicant(s)/Patent Under
Reexamination
EBINA ET AL.

Examiner

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U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| | A | US-6,104,714 | 08-2000 | Baudelot et al. | 370/396 |
| | B | US-6,216,166 | 04-2001 | Zheng et al. | 709/238 |
| | C | US-5,617,419 | 04-1997 | Christensen et al. | 370/471 |
| | D | US-5,636,215 | 06-1997 | Kubo et al. | 370/397 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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| | P | | | | | |
| | Q | | | | | |
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| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
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| | V | |
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